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DIODES, MICROWAVE, SILICON, PIN, ULTRA FAST SWITCHING BASED ON TYPES DH50101 TO DH50107 AND EH50101 TO

EH50107

ESCC Detail Specification No. 5513/038

Issue 8 March 2023



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ESCC Detail Specification

No. 5513/038

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1 **GENERAL**

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics and test and inspection data for the component type variants and/or the range of components specified below. It supplements the requirements of, and shall be read in conjunction with, the ESCC Generic Specification listed under Applicable Documents.

1.2 APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:

- (a) ESCC Generic Specification No. 5010
- (b) MIL-STD-750, Test Methods and Procedures for Semiconductor Devices

1.3 TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply.

1.4 THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS

1.4.1 The ESCC Component Number

The ESCC Component Number shall be constituted as follows:

Example: 551303801

Detail Specification Reference: 5513038

Component Type Variant Number: 01 (as required)

1.4.2 <u>Component Type Variants</u>

The component type variants applicable to this specification are as follows:

Packaged Components

Variant Number	Based On Type	Package Type / Description	Total Capacitance C⊤ (pF)	Mater	erminal ial and Note 1)	Weight Max (g)
			Max	Anode	Cathode	
01	DH50101	Ceramic Pill A (2 Leads)	0.19	E2	E2	0.02
02	DH50101	Ceramic Pill B	0.19	D7	D7	0.02
03	DH50101	Ceramic Pill C (Cathode Lead)	0.19	D7	E2	0.02
04	DH50101	Ceramic Pill D (Anode Lead)	0.19	E2	D7	0.02
05	DH50101	Ceramic Pill E (2 Leads)	0.19	E2	E2	0.02
06	DH50101	Ceramic Pill F (Anode Lead)	0.19	E2	D7	0.02
07	DH50101	Ceramic Pill G	0.26	D7	A7	0.15
08	DH50102	Ceramic Pill A (2 Leads)	0.21	E2	E2	0.02
09	DH50102	Ceramic Pill B	0.21	D7	D7	0.02
10	DH50102	Ceramic Pill C (Cathode Lead)	0.21	D7	E2	0.02
11	DH50102	Ceramic Pill D (Anode Lead)	0.21	E2	D7	0.02





Variant Number	Based On Type	Package Type / Description Total Capacitance C _T (pF) Lead/Terminal Material and Finish (Note 1)		al and	Weight Max (g)	
			Max	Anode	Cathode	
12	DH50102	Ceramic Pill E (2 Leads)	0.21	E2	E2	0.02
13	DH50102	Ceramic Pill F (Anode Lead)	0.21	E2	D7	0.02
14	DH50102	Ceramic Pill G	0.28	D7	A7	0.15
15	DH50103	Ceramic Pill A (2 Leads)	0.25	E2	E2	0.02
16	DH50103	Ceramic Pill B	0.25	D7	D7	0.02
17	DH50103	Ceramic Pill C (Cathode Lead)	0.25	D7	E2	0.02
18	DH50103	Ceramic Pill D (Anode Lead)	0.25	E2	D7	0.02
19	DH50103	Ceramic Pill E (2 Leads)	0.25	E2	E2	0.02
20	DH50103	Ceramic Pill F (Anode Lead)	0.25	E2	D7	0.02
21	DH50103	Ceramic Pill G	0.32	D7	A7	0.15
22	DH50104	Ceramic Pill A (2 Leads)	0.3	E2	E2	0.02
23	DH50104	Ceramic Pill B	0.3	D7	D7	0.02
24	DH50104	Ceramic Pill C (Cathode Lead)	0.3	D7	E2	0.02
25	DH50104	Ceramic Pill D (Anode Lead)	0.3	E2	D7	0.02
26	DH50104	Ceramic Pill E (2 Leads)	0.3	E2	E2	0.02
27	DH50104	Ceramic Pill F (Anode Lead)	0.3	E2	D7	0.02
28	DH50104	Ceramic Pill G	0.37	D7	A7	0.15
29	DH50105	Ceramic Pill A (2 Leads)	0.36	E2	E2	0.02
30	DH50105	Ceramic Pill B	0.36	D7	D7	0.02
31	DH50105	Ceramic Pill C (Cathode Lead)	0.36	D7	E2	0.02
32	DH50105	Ceramic Pill D (Anode Lead)	0.36	E2	D7	0.02
33	DH50105	Ceramic Pill E (2 Leads)	0.36	E2	E2	0.02
34	DH50105	Ceramic Pill F (Anode Lead)	0.36	E2	D7	0.02
35	DH50105	Ceramic Pill G	0.43	D7	A7	0.15
36	DH50106	Ceramic Pill A (2 Leads)	0.53	E2	E2	0.02
37	DH50106	Ceramic Pill B	0.53	D7	D7	0.02
38	DH50106	Ceramic Pill C (Cathode Lead)	0.53	D7	E2	0.02
39	DH50106	Ceramic Pill D (Anode Lead)	0.53	E2	D7	0.02
40	DH50106	Ceramic Pill E (2 Leads)	0.53	E2	E2	0.02
41	DH50106	Ceramic Pill F (Anode Lead)	0.53	E2	D7	0.02
42	DH50106	Ceramic Pill G	0.6	D7	A7	0.15
43	DH50107	Ceramic Pill A (2 Leads)	0.73	E2	E2	0.02
44	DH50107	Ceramic Pill B	0.73	D7	D7	0.02
45	DH50107	Ceramic Pill C (Cathode Lead)	0.73	D7	E2	0.02
46	DH50107	Ceramic Pill D (Anode Lead)	0.73	E2	D7	0.02



Variant Number	Based On Type	Package Type / Description	Total Capacitance C _T (pF) Max	Mater	erminal ial and Note 1) Cathode	Weight Max (g)
47	DH50107	Ceramic Pill E (2 Leads)	0.73	E2	E2	0.02
48	DH50107	Ceramic Pill F (Anode Lead)	0.73	E2	D7	0.02
49	DH50107	Ceramic Pill G	0.8	D7	A7	0.15

Die Components (Note 2)

Variant Number	Based On Type	Junction Capacitance C _J (pF) Max	Total Capacitance C _T (pF) Max (Note 3)
57	EH50101	0.06	0.26
58	EH50102	0.08	0.28
59	EH50103	0.12	0.32
60	EH50104	0.17	0.37
61	EH50105	0.23	0.43
62	EH50106	0.4	0.6
63	EH50107	0.6	0.8

NOTES:

- The lead/terminal material and finish shall be in accordance with the requirements of ESCC Basic Specification No. 23500.
- 2. For Die Components, Variants 57 to 63, the default package selected for assembly of the Packaged Test Sublot shall be Ceramic Pill G. At the Manufacturer's option, any of the other packages specified herein with a Variant for the same die may be selected. The die applicable to each Variant is indicated by the based on type number.
- 3. In cases where the default package is not selected for the Packaged Test Sublot, the Total Capacitance limit of the selected package shall apply.



1.5 MAXIMUM RATINGS

The maximum ratings shall not be exceeded at any time during use or storage.

Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Generic Specification.

Characteristics	Symbols	Maximum Ratings	Unit	Remarks
DC Reverse Voltage	V_{Rmax}	-70	V	I _R = 10μA
DC Forward Current (Continuous) Variants 01 to 06, 08 to 13, 15 to 20, 22 to 27, 29 to 34: Variants 07, 14, 21, 28, 35: Variants 36 to 41, 43 to 48: Variants 42, 49:	lFmax	150 240 180 300	mA	Note 1
RF Power Dissipation Variants 01 to 06, 08 to 13, 15 to 20, 22 to 27, 29 to 34: Variants 07, 14, 21, 28, 35: Variants 36 to 41, 43 to 48: Variants 42, 49:	P _{tot}	0.5 0.83 0.62 1.25	W	Note 2
Operating Temperature Range	Top	-55 to +150	°C	T _{case}
Storage Temperature Range	T _{stg}	-65 to +175	ô	
Junction Temperature	Tj	+150	°C	
Thermal Resistance, Junction-to-Case Variants 01 to 06, 08 to 13, 15 to 20, 22 to 27, 29 to 34: Variants 07, 14, 21, 28, 35, 57 to 61: Variants 36 to 41, 43 to 48: Variants 42, 49, 62, 63:	R _{th(j-c)}	150 90 120 60	°C/W	Note 3
Soldering Temperature	T _{sol}	+230	°C	Note 4

NOTES:

- 1. At $T_{case} \le +75^{\circ}$ C. For $T_{case} > +75^{\circ}$ C, derate linearly to 0A at $T_{case} = +150^{\circ}$ C.
- 2. At $T_{case} \le +75$ °C. For $T_{case} > +75$ °C, derate linearly to 0W at $T_{case} = +150$ °C.
- 3. Thermal Resistance ratings for Die Components, Variants 57 to 63, refer to the Packaged Test Sublot assembled in the default Ceramic Pill G package. In cases where the default package is not used, the Thermal Resistance rating associated with the package used and the same die shall apply.
- 4. Duration 5 seconds maximum and the same terminal shall not be resoldered until 3 minutes have elapsed. Only applicable to Variants 01 to 49 (Packaged Components).

1.6 <u>HANDLING PRECAUTIONS</u>

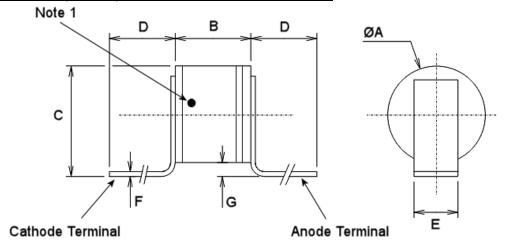
These devices are susceptible to damage by electrostatic discharge. Therefore, suitable precautions shall be employed for protection during all phases of manufacture, testing, packaging, shipment and any handling.

These components are categorised as Class 1 per ESCC Basic Specification No. 23800 with a Minimum Critical Path Failure Voltage of 500V.



1.7 PHYSICAL DIMENSIONS AND TERMINAL IDENTIFICATION

1.7.1 <u>Ceramic Pill A (2 Leads) - Variants 01, 08, 15, 22, 29, 36, 43</u>



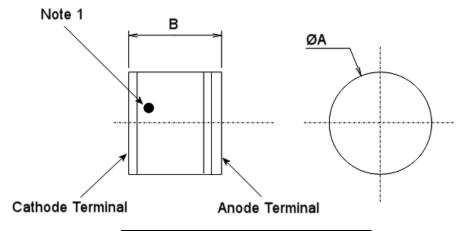
Symbols	Dimensions mm		Remarks
	Min	Max	
ØA	1.07	1.47	
В	0.95	1.35	
С	1.3	1.9	Both terminals
D	2.5	-	
Е	0.55	0.65	Both terminals
F	0.06	0.1	Both terminals
G	0.1	0.5	Both terminals

NOTES:

1. Terminal identification: The body shall be marked at a suitable location near the cathode terminal with a black dot.



1.7.2 <u>Ceramic Pill B - Variants 02, 09, 16, 23, 30, 37, 44</u>



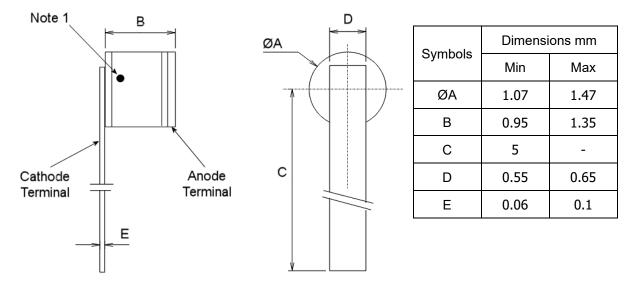
Cymah ala	Dimensions mm		
Symbols	Min	Max	
ØA	1.07	1.47	
В	0.95	1.35	

NOTES:

Terminal identification: The body shall be marked at a suitable location near the cathode terminal with a black dot.



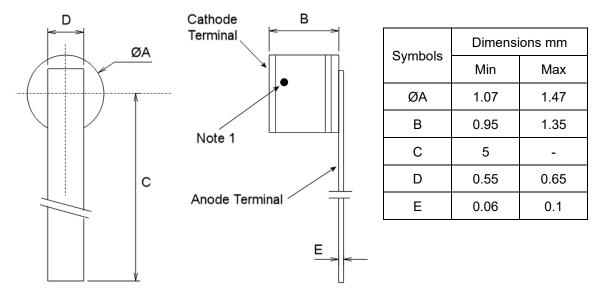
Ceramic Pill C (Cathode Lead) - Variants 03, 10, 17, 24, 31, 38, 45 1.7.3



Terminal identification: The body shall be marked at a suitable location near the cathode terminal with a black dot.



1.7.4 Ceramic Pill D (Anode Lead) - Variants 04, 11, 18, 25, 32, 39, 46

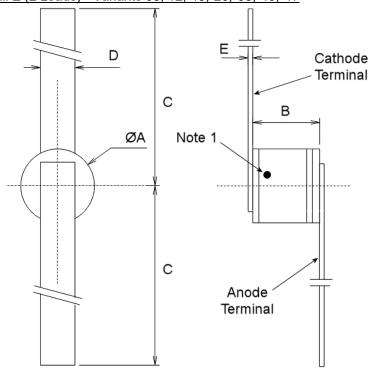


NOTES:

1. Terminal identification: The body shall be marked at a suitable location near the cathode terminal with a black dot.



1.7.5 Ceramic Pill E (2 Leads) - Variants 05, 12, 19, 26, 33, 40, 47



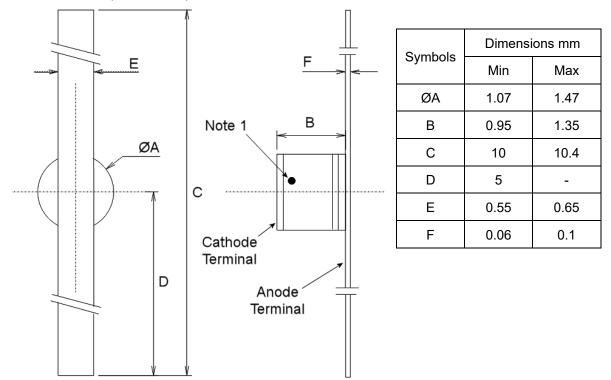
Cymahala	Dimensions mm		Domorko	
Symbols	Min	Max	Remarks	
ØA	1.07	1.47		
В	0.95	1.35		
С	5	-		
D	0.55	0.65	Both terminals	
Е	0.06	0.1	Both terminals	

NOTES:

1. Terminal identification: The body shall be marked at a suitable location near the cathode terminal with a black dot.



1.7.6 Ceramic Pill F (Anode Lead) - Variants 06, 13, 20, 27, 34, 41, 48

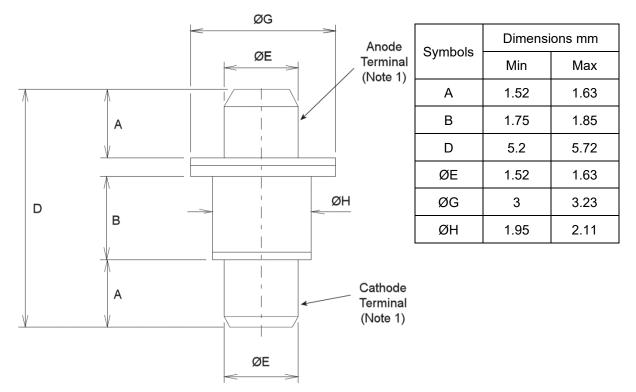


NOTES:

1. Terminal identification: The body shall be marked at a suitable location near the cathode terminal with a black dot.



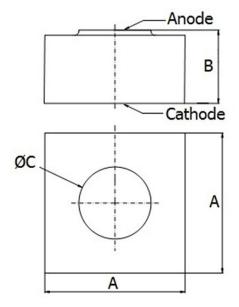
1.7.7 <u>Ceramic Pill G - Variants 07, 14, 21, 28, 35, 42, 49</u>



NOTES:

1. Terminal identification shall be by means of the physical configuration of the package.

1.7.8 Die – Variants 57 to 63



Symbolo	Dimensi	ions mm	Remarks	
Symbols	Min	Max	Nemarks	
Α	0.34	0.4		
В	0.16	0.26		
	0.04	0.08	Variant 57	
	0.05	0.1	Variant 58	
	0.06	0.12	Variant 59	
ØС	0.08	0.14	Variant 60	
	0.1	0.16	Variant 61	
	0.14	0.2	Variant 62	
	0.16	0.23	Variant 63	

NOTES:

- Terminal identification shall be by means of the physical configuration.
- 2. Die construction, materials, finishes:
 - Die substrate: Silicon
 - Bond pad: The metallisation shall be TiPtAu with a layer of vacuum-deposited gold of thickness 0.7µm minimum.
 - Die backface: The metallisation shall be TiPtAu with a layer of gold of thickness 0.7μm minimum
 - Glassivation: Silicon oxide of thickness 0.7µm typical.

1.8 <u>FUNCTIONAL DIAGRAM</u>



- 1. Anode
- 2. Cathode



1.9 <u>MATERIALS AND FINISHES</u>

1.9.1 Materials and Finishes of Packaged Components

For Variants 01 to 49, the materials and finishes shall be as follows:

(a) Case

The case shall be hermetically sealed and have a ceramic body with a metal base and lid.

(b) Terminals

As specified in Para. 1.4.2.

1.9.2 Materials and Finishes of Die Components

For Variants 57 to 63, the materials and finishes shall be as specified in Para. 1.7.9.

2 **REQUIREMENTS**

2.1 GENERAL

The complete requirements for procurement of the components specified herein are as stated in this specification and the ESCC Generic Specification. Permitted deviations from the Generic Specification, applicable to this specification only, are listed below.

Permitted deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirement and do not affect the component's reliability, are listed in the appendices attached to this specification.

2.1.1 <u>Deviations from the Generic Specification</u>

2.1.1.1 Deviations from Qualification and Periodic Tests – Chart F4

- (a) Mechanical Shock: Shall not be performed.
- (b) Vibration: Shall not be performed.
- (c) Constant Acceleration: Shall not be performed.

2.2 MARKING

The marking shall be in accordance with the requirements of ESCC Basic Specification No. 21700 and as follows.

The information to be marked on the component or its primary package shall be:

- (a) Terminal identification, as specified in Para. 1.7.
- (b) The ESCC qualified components symbol (for ESCC qualified components only).
- (c) The ESCC Component Number.
- (d) Traceability information.

2.3 DIE SHEAR

In those cases where package clearances are such that a die shear test is not practicable, the die shall be pushed away with a suitable tool. The force required to remove the die need not be recorded. The die attachment area shall be inspected and the component shall be considered acceptable if more than 50% of the semiconductor material remains.



2.4 <u>TERMINAL STRENGTH</u>

The test conditions for terminal strength, tested as specified in the ESCC Generic Specification, shall be as follows:

- For Variants 01, 03 to 06, 08, 10 to 13, 15, 17 to 20, 22, 24 to 27, 29, 31 to 34, 36, 38 to 41, 43, 45 to 48: Test Condition A, tension, with a force of 1.25N for duration 10s.
- For Variants 02, 07, 09, 14, 16, 21, 23, 28, 30, 35, 37, 42, 44, 49: shall not be performed.
- For Variants 57 to 63: not applicable.

2.5 <u>ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES</u>

2.5.1 Room Temperature Electrical Measurements

The measurements shall be performed at T_{amb} = +22 ±3°C.

Characteristics	Symbols	MIL-STD-750	Test Conditions	ons Limits		Units
		Test Method		Min	Max	
Reverse Current 1 (Note 1)	I _{R1}	4016	V _R = -100V	ı	10	μA
Reverse Current 2 (Note 1)	I _{R2}	4016	V _R = -50V	-	100	nA
Forward Voltage (Note 1)	VF	4011	I _F = 10mA	-	1.1	V
Thermal Resistance, Junction-to-Case (Note 2)	R _{th(j-c)}	3101	Note 3	-	Note 4	°C/W
Variants 01 to 06, 08 to 13, 15 to 20, 22 to 27, 29 to 34:			P = 0.25W			
Variants 07, 14, 21, 28, 35 to 41, 43 to 48, 57 to 61:			P = 0.5W			
Variants 42, 49, 62, 63:			P = 1W			
Total Capacitance (Note 2)	Ст	4001	$V_R = -6V$ f = 1MHz	-	Note 5	pF
Junction Capacitance (Note 6)	Сл	4001	V _R = -6V f = 1MHz	-	Note 5	pF
Forward Series Resistance (Note 1)	RsF	4056	I _F = 10mA f = 120MHz			Ω
Variants 01 to 07, 57:				-	1.9	
Variants 08 to 14, 58:				-	1.7	
Variants 15 to 21, 59:				-	1.4	
Variants 22 to 28, 60:				-	1.2	
Variants 29 to 35, 61:				-	0.8	
Variants 36 to 42, 62: Variants 43 to 49, 63:				-	0.8	

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Characteristics	•		Test Conditions	Limits		Units
		Test Method		Min	Max	
Minority Carrier Lifetime (Note 7)	τL	4031	I _F = 10mA I _R = 6mA			ns
Variants 01 to 07, 57: Variants 08 to 14, 58: Variants 15 to 21, 59: Variants 22 to 28, 60:				- - -	300 300 400 500	
Variants 22 to 26, 60. Variants 29 to 35, 61: Variants 36 to 42, 62: Variants 43 to 49, 63:				- - -	600 800 1000	

NOTES:

- This characteristic applies to all Variants tested during Charts F2 and F3 of the Generic Specification.
- 2. This characteristic applies to Variants 01 to 49 (Packaged Components) and Variants 57 to 63 (Packaged Test Sublot samples for Die Components), tested only during Chart F3 of the Generic Specification.
- 3. Pulsed measurement, pulse width = 10ms.
- 4. See Para. 1.5 for the applicable limits.
- 5. See Para. 1.4.2 for the applicable limits.
- 6. This characteristic only applies to Variants 57 to 63 (Die Components), tested only during Chart F2 of the Generic Specification.
- 7. Only performed during Chart F2 of the Generic Specification, on a sample of 27 dice per wafer. In the event of any failure, a 100% inspection shall be performed and all failures shall be clearly identified.

2.5.2 High and Low Temperatures Electrical Measurements

The measurements shall be performed only at $T_{amb} = +150 (+0 -3)^{\circ}C$.

Characteristics	Symbols	MIL-STD-750 Test Method	Test Conditions Note 1	Limits		Units
				Min	Max	
Reverse Current 2 (Note 2)	I _{R2}	4016	V _R = -50V	-	1	μA

NOTES:

- 1. Measurements shall be performed on a sample basis as specified in the Generic Specification.
- 2. This characteristic applies to all Variants tested during Charts F2 and F3 of the Generic Specification.



2.6 PARAMETER DRIFT VALUES

Unless otherwise specified, the measurements shall be performed at T_{amb} = +22 ±3°C.

The test methods and test conditions shall be as per the corresponding test defined in Para. 2.5.1, Room Temperature Electrical Measurements.

The drift values (Δ) shall not be exceeded for each characteristic specified. The corresponding absolute limit values for each characteristic shall not be exceeded.

Characteristics	Symbols	Limits			Units
		Drift			
		Value (1) Δ	Min	Max	
Reverse Current 2	I _{R2}	±10 or (2) ±100%	-	100	nA
Forward Voltage	V _F	±5%	-	1.1	V
Total Capacitance (Note 3)	Ст	±5% (4) or ±10% (5)	-	Note 6	pF

NOTES:

- 1. $\Delta 1 = \Delta 2$.
- 2. Whichever is the greater referred to the initial value.
- 3. This characteristic applies to Variants 01 to 49 (Packaged Components) and Variants 57 to 63 (Packaged Test Sublot samples for Die Components).
- 4. Applicable drift value for $C_T > 0.5pF$ and rounded upwards to the nearest 0.01pF.
- 5. Applicable drift value for $C_T \le 0.5pF$ and rounded upwards to the nearest 0.01pF.
- 6. See Para. 1.4.2 for the applicable limits.

2.7 INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS

Unless otherwise specified, the measurements shall be performed at T_{amb} = +22 ±3°C.

The test methods and test conditions shall be as per the corresponding test defined in Para. 2.5.1, Room Temperature Electrical Measurements.

The limit values for each characteristic shall not be exceeded.

Characteristics	Symbols	Limits		Units
		Min	Max	
Reverse Current 1	I _{R1}	-	10	μΑ
Reverse Current 2	I _{R2}	-	100	nA
Forward Voltage	V _F	-	1.1	V
Total Capacitance (Note 1)	Ст	-	Note 2	pF

NOTES:

This characteristic applies to Variants 01 to 49 (Packaged Components) and Variants 57 to 63 (Packaged Test Sublot samples for Die Components).



2. See Para. 1.4.2 for the applicable limits.

2.8 <u>BURN-IN 1 CONDITIONS</u>

Characteristics	Symbols	Test Conditions	Units
Ambient Temperature	T _{amb}	+150 (+0 -3)	°C
Reverse Voltage (Note 1)	V_R	-75	V

NOTES:

Upon completion of Burn-in 1, the test voltage shall be maintained until T_{amb} < +35°C.

2.9 <u>BURN-IN 2 CONDITIONS</u>

Characteristics	Symbols	Test Conditions	Units
Case Temperature	T _{case}	+125 (+0 -3)	°C
Forward Current	l _F		mA
Variants 01 to 06, 08 to 13, 15 to 20, 22 to 27, 29 to 34:		50	
Variants 07, 14, 21, 28, 35, 57 to 61:		80	
Variants 36 to 41, 43 to 48:		60	
Variants 42, 49, 62, 63:		100	

2.10 OPERATING LIFE CONDITIONS

The conditions shall be as specified in Para 2.9.



APPENDIX 'A' AGREED DEVIATIONS FOR EXENS SOLUTIONS (F)

Items Affected	Description of Deviations
Para. 2.1.1, Deviations from the Generic Specification:	SEM Inspection: From each wafer selected for SEM Inspection, the sample of three dice shall be selected after die separation.
Deviations from Special In- Process Controls – Chart F2	Bond Strength: The following pre-seal bond strength shall apply: • 0.03N minimum
Para. 2.1.1, Deviations from the Generic Specification: Deviations from Screening Tests for Packaged Components – Chart F3A	 Radiographic Inspection: May be performed without serialisation and at any point during Chart F3A. Any components found to fail Radiographic Inspection shall be removed from the lot. May be performed in the X and Z axes only.
Para. 2.1.1.1, Deviations from Qualification and Periodic Tests – Chart F4	For the De-encapsulation Subgroup, the Internal Visual Inspection, Bond Strength and Die Shear tests may be replaced by measurements verifying the die solder integrity and wire integrity, as follows:
	Thermal Impedance test in accordance with MIL-STD-750, Test Method 3101.
	 For Variants 01 to 06, 08 to 13, 15 to 20, 22 to 27, 29 to 34: P_D = 0.25W. For Variants 07, 14, 21, 28, 35 to 41, 43 to 48, 57 to 61: P_D = 0.5W. For Variants 42, 49, 62, 63: P_D = 1W.
	The Thermal Impedance shall be measured and shall not exceed the applicable value of Thermal Resistance, Junction-to-Case specified in Para. 1.5 herein.
	Forward Voltage test in accordance with MIL-STD-750, Test Method 4011.
	• I _F = 100mA.
	The Forward Voltage shall be measured and shall not exceed 1.2V.